Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/533,453	TAKAHASHI ET AL.	
Examiner	Art Unit	_
Johannes P. Mondt	3663	

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
Text srch incl PGPUB, see interference printout		7/21/2007	JPM

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
cf. Search History: 376/(190,199,200,201)	7/21/2007	JPM		
inventor name srch	7/21/2007	JPM		
INSPEC	7/21/2007	JPM		
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